

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/563,423	SHINKAWA ET AL.	
Examiner			Art Unit	1793	Page 1 of 1
Nicholas P. D'Aniello					

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*	C	US-4,583,144	04-1986	Kato, Yoshitake	360/133
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